

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Alan Wong et al. Art Unit : 2811
Serial No. : 10/083,877 Examiner : Unknown
Filed : February 25, 2002
Title : OPTICAL METROLOGY TARGET DESIGN FOR SIMULTANEOUS
MEASUREMENT OF MULTIPLE PERIODIC STRUCTURES

Attention: Official Draftsman
Commissioner for Patents
Washington, D.C. 20231


TRANSMITTAL OF FORMAL DRAWINGS

Please substitute the enclosed nine (9) sheets of formal drawings for the corresponding drawings presently in the application.

Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: April 22, 2002


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